

Search Notes**Application/Control No.**

10/721,875

Examiner

ALEX LIEW

Applicant(s)/Patent under Reexamination

ENDO ET AL.

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Interference search		3/12/2008	AL

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
382/106,154 limited to text search	4/23/2007	AL
348/36-39 limited to text search	4/23/2007	AL
382/274 limited to text search	4/25/2007	AL
382/106,154 limited to text search 382 limited to text search 348/36-39 limited to text search	12/21/2007	AL
382/106,154 limited to text search 382 limited to text search 348/36-39 limited to text search	3/12/2008	AL
Inventor name search	3/12/2008	AL